

The Wideband IC Line

RF LDMOS Wideband Integrated Power Amplifiers

The MW4IC2020M wideband integrated circuit is designed for base station applications. It uses Motorola's newest High Voltage (26 to 28 Volts) LDMOS IC technology and integrates a multi-stage structure. Its wideband On-Chip design makes it usable from 1600 to 2400 MHz. The linearity performances cover all modulations for cellular applications: GSM, GSM EDGE, CDMA, CDMA and W-CDMA.

Final Application

Typical Two-Tone Performance: $V_{DD} = 26$ Volts, $I_{DQ1} = 80$ mA, $I_{DQ2} = 200$ mA, $I_{DQ3} = 300$ mA, $P_{out} = 20$ Watts PEP, Full Frequency Band
Power Gain — 29 dB
IMD — -32 dBc
Drain Efficiency — 26% (at 1805 MHz) and 20% (at 1990 MHz)

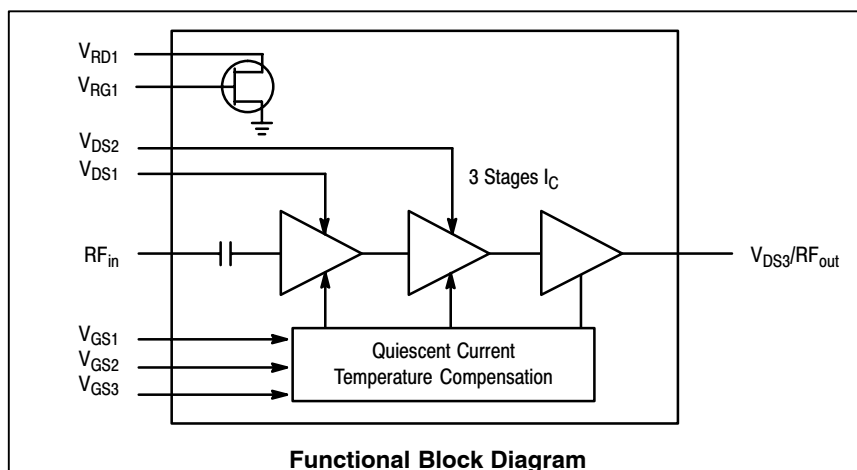
Driver Applications

Typical GSM EDGE Performance: $V_{DD} = 26$ Volts, $I_{DQ1} = 80$ mA, $I_{DQ2} = 230$ mA, $I_{DQ3} = 230$ mA, $P_{out} = 5$ Watts Avg., Full Frequency Band
Power Gain — 29 dB
Spectral Regrowth @ 400 kHz Offset = -66 dBc
Spectral Regrowth @ 600 kHz Offset = -77 dBc
EVM — 1% rms

Typical CDMA Performance: $V_{DD} = 26$ Volts, $I_{DQ1} = 80$ mA, $I_{DQ2} = 240$ mA, $I_{DQ3} = 250$ mA, $P_{out} = 1$ Watt Avg., Full Frequency Band, IS-97 Pilot, Sync, Paging, Traffic Codes 8 through 13

Power Gain — 30 dB
ACPR @ 885 kHz Offset = -61 dBc @ 30 kHz Bandwidth
ALT1 @ 1.25 MHz Offset = -69 dBc @ 12.5 kHz Bandwidth
ALT2 @ 2.25 MHz Offset = -59 dBc @ 1 MHz Bandwidth

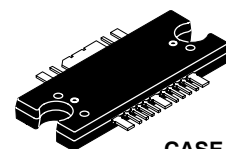
- Capable of Handling 3:1 VSWR, @ 26 Vdc, 1990 MHz, 8 Watts CW Output Power
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- On-Chip Matching (50 Ohm Input, DC Blocked, >5 Ohm Output)
- Integrated Temperature Compensation with Enable/Disable Function
- On-Chip Current Mirror g_m Reference FET for Self Biasing Application (1)
- Integrated ESD Protection
- Also Available in Gull Wing for Surface Mount
- In Tape and Reel. R1 Suffix = 500 Units per 44 mm, 13 inch Reel



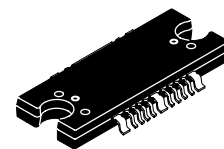
(1) Refer to AN1987/D, *Quiescent Current Control for the RF Integrated Circuit Device Family*. Go to <http://www.motorola.com/semiconductors/rf>. Select Documentation/Application Notes - AN1987.

MW4IC2020MBR1
MW4IC2020GMBR1

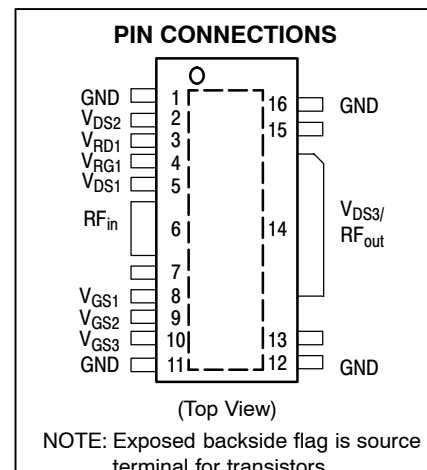
1805 - 1990 MHz, 20 W, 26 V
GSM/GSM EDGE, CDMA
RF LDMOS WIDEBAND
INTEGRATED POWER AMPLIFIERS



CASE 1329-09
TO-272 WB-16
PLASTIC
MW4IC2020MBR1



CASE 1329A-03
TO-272 WB-16 GULL
PLASTIC
MW4IC2020GMBR1



MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	65	Vdc
Gate-Source Voltage	V_{GS}	-0.5, +15	Vdc
Storage Temperature Range	T_{stg}	-65 to +175	°C
Operating Junction Temperature	T_J	175	°C
Input Power	P_{in}	20	dBm

THERMAL CHARACTERISTICS

Characteristic	Symbol	Value (1)	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	10.5 5.1 2.3	°C/W
Stage 1			
Stage 2			
Stage 3			

ESD PROTECTION CHARACTERISTICS

Test Conditions	Class
Human Body Model	2 (Minimum)
Machine Model	M3 (Minimum)
Charge Device Model	C5 (Minimum)

MOISTURE SENSITIVITY LEVEL

Test Methodology	Rating
Per JESD 22-A113	3

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
----------------	--------	-----	-----	-----	------

FUNCTIONAL TESTS (In Motorola Wideband 1805-1990 MHz Test Fixture, 50 ohm system) $V_{DD} = 26$ Vdc, $I_{DQ1} = 80$ mA, $I_{DQ2} = 200$ mA, $I_{DQ3} = 300$ mA, $P_{out} = 20$ W PEP, $f_1 = 1990$ MHz, $f_2 = 1990.1$ MHz and $f_1 = 1805$ MHz, $f_2 = 1805.1$ MHz, Two-Tone CW

Power Gain	G_{ps}	27	29	—	dB
Drain Efficiency $f_1 = 1805$ MHz, $f_2 = 1805.1$ MHz $f_1 = 1990$ MHz, $f_2 = 1990.1$ MHz	η_D	24 18	26 20	—	%
Input Return Loss	IRL	—	—	-10	dB
Intermodulation Distortion	IMD	—	-32	-27	dBc
Stability (100 mW < P_{out} < 8 W CW, Load VSWR = 3:1, All Phase Angles)		No Spurious > -60 dBc			

TYPICAL PERFORMANCES (In Motorola Test Fixture, 50 ohm system) $V_{DD} = 26$ Vdc, $I_{DQ1} = 80$ mA, $I_{DQ2} = 200$ mA, $I_{DQ3} = 300$ mA, 1805 MHz < Frequency < 1990 MHz, 1-Tone

Saturated Pulsed Output Power ($f = 1$ kHz, Duty Cycle 10%)	P_{sat}	—	33	—	Watts
Quiescent Current Accuracy over Temperature (-10 to 85°C)	ΔI_{QT}	—	±5	—	%
Gain Flatness in 30 MHz Bandwidth @ $P_{out} = 1$ W CW	G_F	—	0.15	—	dB
Deviation from Linear Phase in 30 MHz Bandwidth @ $P_{out} = 1$ W CW 1805-1880 MHz 1930-1990 MHz	Φ	—	±0.5 ±0.2	—	°
Delay @ $P_{out} = 1$ W CW Including Output Matching	Delay	—	1.8	—	ns
Part to Part Phase Variation @ $P_{out} = 1$ W CW	$\Phi\Delta$	—	±10	—	°

(1) MTTF calculator available at <http://www.motorola.com/semiconductors/rf>. Select Tools/Software/Application Software/Calculators to access the MTTF calculators by product.

(continued)

ELECTRICAL CHARACTERISTICS — continued ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
TYPICAL CDMA PERFORMANCES (In Modified CDMA Test Fixture, 50 ohm system) $V_{DD} = 26\text{ Vdc}$, $I_{DQ1} = 80\text{ mA}$, $I_{DQ2} = 240\text{ mA}$, $I_{DQ3} = 250\text{ mA}$, $P_{out} = 1\text{ W Avg.}$, 11930 MHz < Frequency < 1990 MHz, 1-Tone, 9 Channel Forward Model (Pilot, Paging, Sync, Traffic Codes 8 through 13). Peak/Avg. Ratio 9.8 dB @ 0.01% Probability on CCDF.					
Power Gain	G_{ps}	—	30	—	dB
Drain Efficiency	η_D	—	5	—	%
Adjacent Channel Power Ratio ($\pm 885\text{ kHz @ } 30\text{ kHz Bandwidth}$)	ACPR	—	-61	—	dBc
Alternate 1 Channel Power Ratio ($\pm 1.25\text{ MHz @ } 12.5\text{ kHz Bandwidth}$)	ALT1	—	-69	—	dBc
Alternate 2 Channel Power Ratio ($\pm 2.25\text{ MHz @ } 1\text{ MHz Bandwidth}$)	ALT2	—	-59	—	dBc

TYPICAL GSM EDGE PERFORMANCES (In Modified GSM EDGE Test Fixture, 50 ohm system) $V_{DD} = 26\text{ Vdc}$, $I_{DQ1} = 80\text{ mA}$, $I_{DQ2} = 230\text{ mA}$, $I_{DQ3} = 230\text{ mA}$, $P_{out} = 5\text{ W Avg.}$, 1805 MHz < Frequency < 1990 MHz

Power Gain	G_{ps}	—	29	—	dB
Drain Efficiency	η_D	—	15	—	%
Error Vector Magnitude	EVM	—	1	—	% rms
Spectral Regrowth at 400 kHz Offset	SR1	—	-66	—	dBc
Spectral Regrowth at 600 kHz Offset	SR2	—	-77	—	dBc

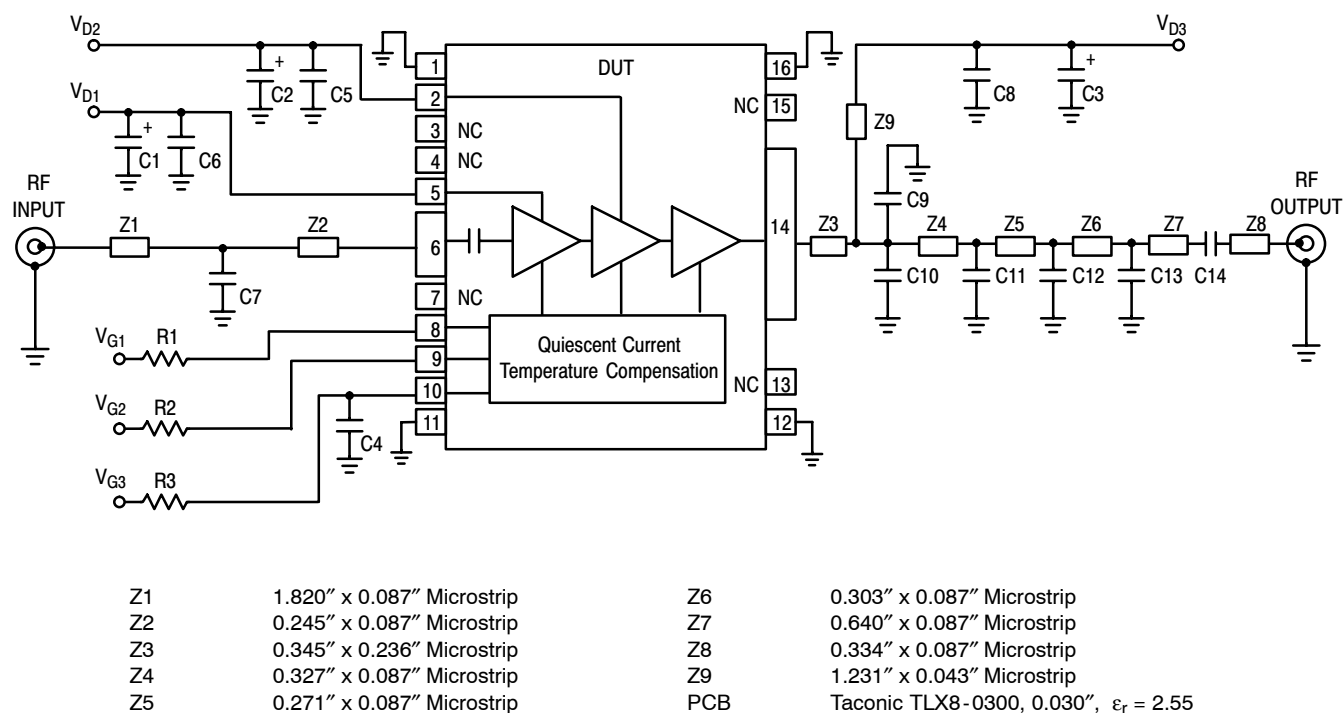


Figure 1. MW4IC2020MBR1(GMBR1) Test Circuit Schematic

Table 1. MW4IC2020MBR1(GMBR1) Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
C1, C2, C3	10 μ F, 35 V Tantalum Capacitors	TAJE226M035	AVX
C4	220 nF Chip Capacitor (1206)	12065C224K28	AVX
C5, C6, C8	6.8 pF 100B Chip Capacitors	100B6R8CW	ATC
C7	0.5 pF 100B Chip Capacitor	100B0R5BW	ATC
C9, C11	1.8 pF 100B Chip Capacitors	100B1R8BW	ATC
C10	2.2 pF 100B Chip Capacitor	100B2R2BW	ATC
C12	1 pF 100B Chip Capacitor	100B1R0BW	ATC
C13	0.3 pF 100B Chip Capacitor	100B0R3BW	ATC
C14	10 pF 100B Chip Capacitor	100B100GW	ATC
R1, R2, R3	1.8 k Ω Chip Resistors (1206)		

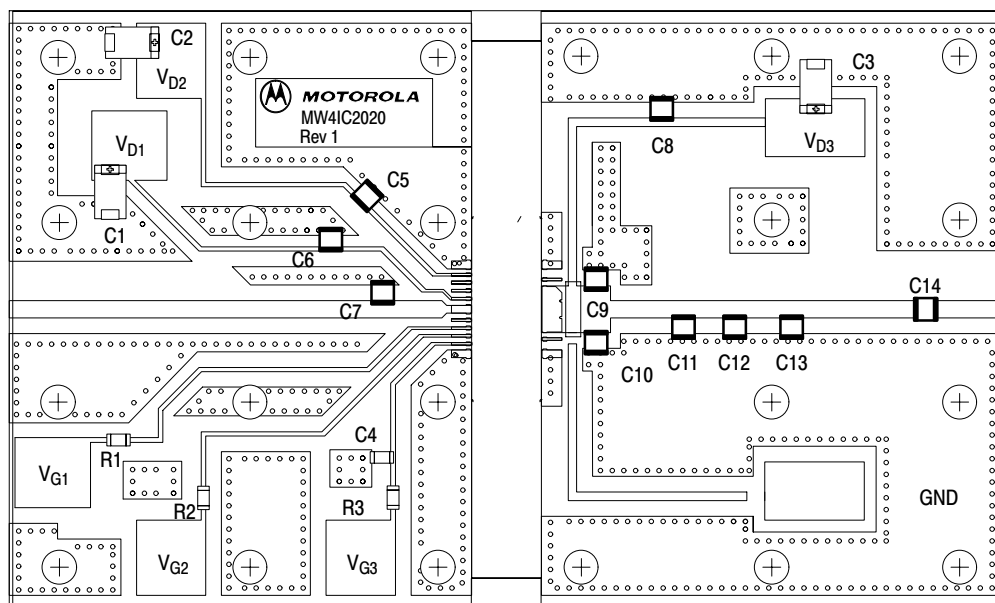


Figure 2. MW4IC2020MBR1(GMBR1) Test Circuit Component Layout

TYPICAL CHARACTERISTICS

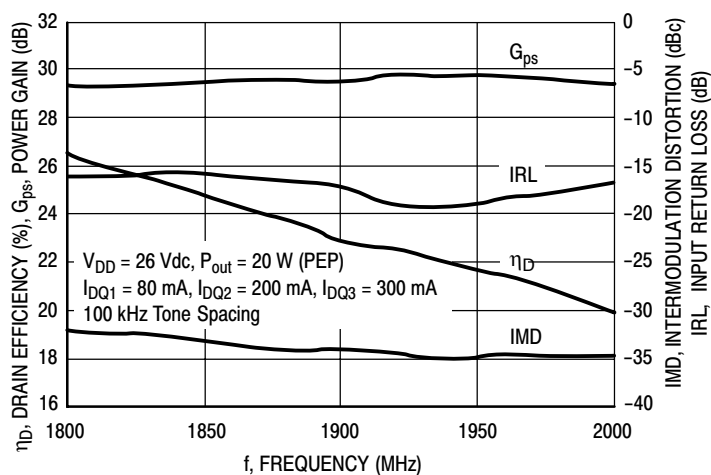


Figure 3. Two-Tone Wideband Performance

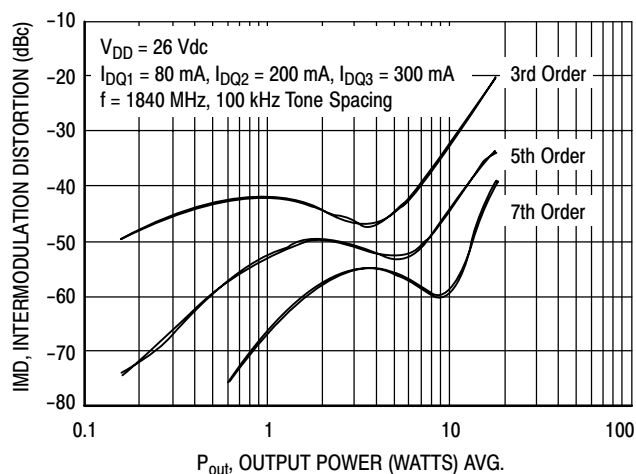


Figure 4. Intermodulation Distortion Products versus Output Power

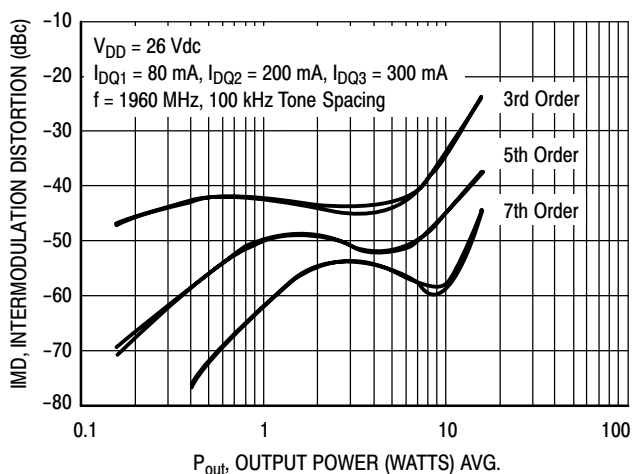


Figure 5. Intermodulation Distortion Products versus Output Power

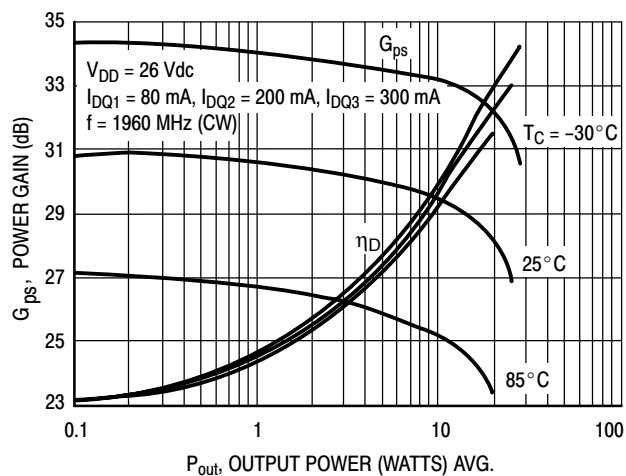


Figure 6. Power Gain and Drain Efficiency versus Output Power

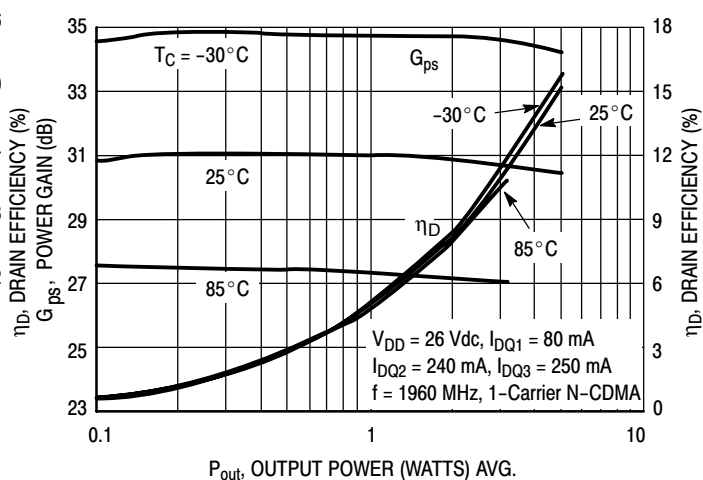


Figure 7. Power Gain and Drain Efficiency versus Output Power

TYPICAL CHARACTERISTICS

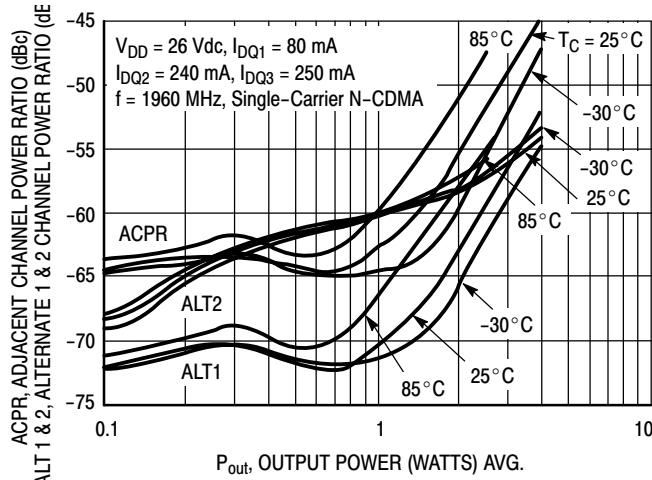


Figure 8. Alternate Channel Power Ratio, Alternate 1 and 2 Channel Power Ratio versus Output Power

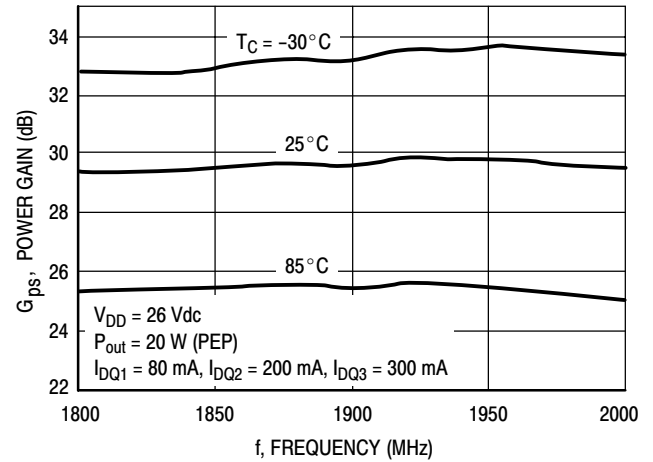


Figure 9. Power Gain versus Frequency

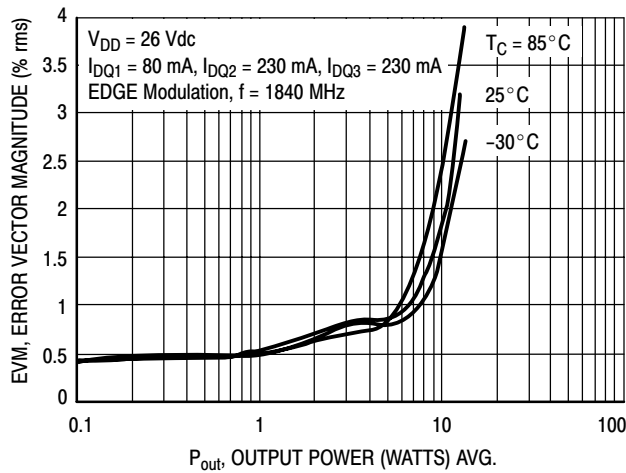


Figure 10. Error Vector Magnitude versus Output Power

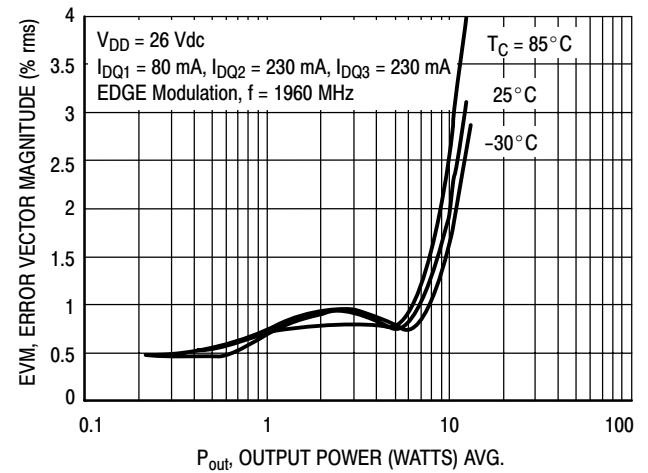


Figure 11. Error Vector Magnitude versus Output Power

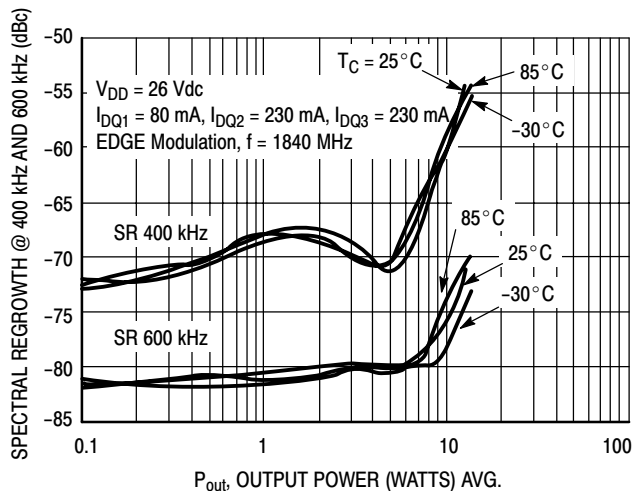


Figure 12. Spectral Regrowth at 400 and 600 kHz versus Output Power

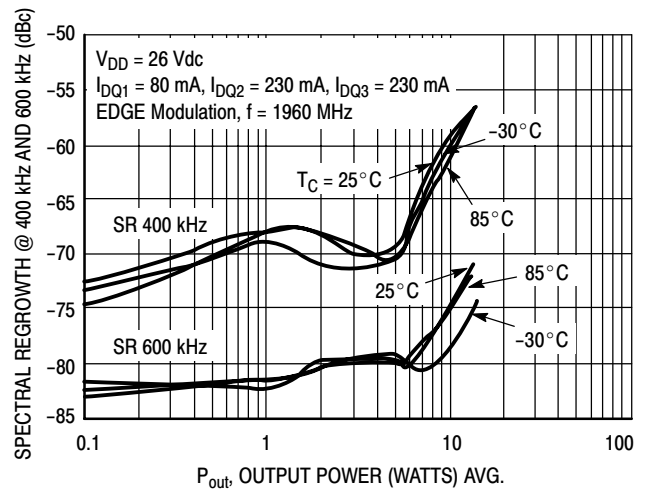
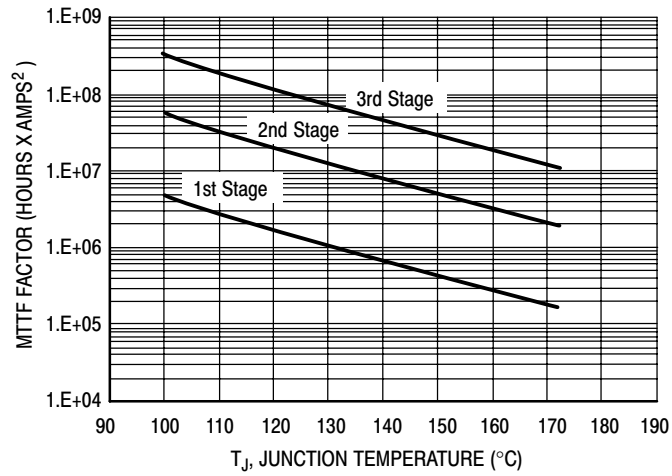


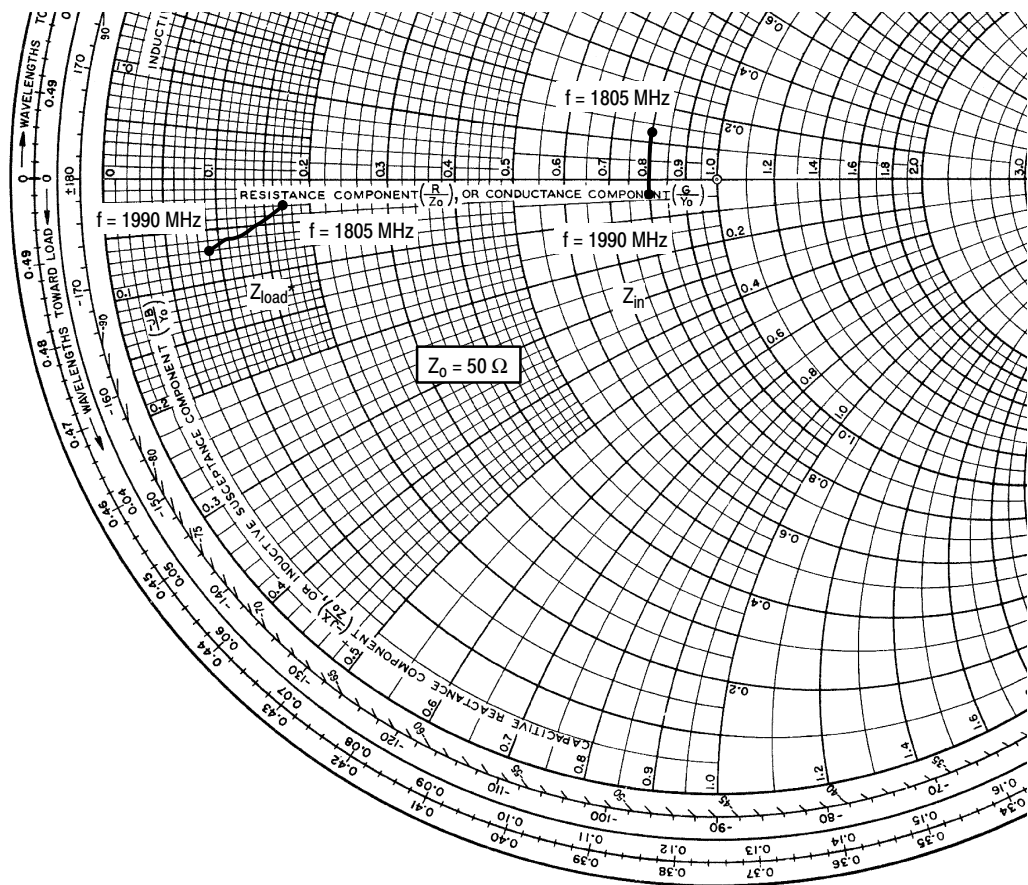
Figure 13. Spectral Regrowth at 400 and 600 kHz versus Output Power

TYPICAL CHARACTERISTICS



This above graph displays calculated MTTF in hours x ampere² drain current. Life tests at elevated temperatures have correlated to better than $\pm 10\%$ of the theoretical prediction for metal failure. Divide MTTF factor by I_D^2 for MTTF in a particular application.

Figure 14. MTTF Factor versus Junction Temperature



$V_{DD} = 26 \text{ V}$, $I_{DQ1} = 80 \text{ mA}$, $I_{DQ2} = 200 \text{ mA}$, $I_{DQ1} = 300 \text{ mA}$, $P_{out} = 20 \text{ W PEP Two-Tone CW}$

f MHz	Z_{in} Ω	Z_{load} Ω
1805	$40.00 + j6.50$	$8.75 - j1.42$
1842	$40.00 + j2.00$	$7.00 - j2.70$
1880	$40.00 - j1.50$	$5.90 - j2.97$
1930	$40.00 - j1.80$	$5.46 - j3.20$
1960	$40.00 - j2.10$	$4.30 - j3.35$
1990	$40.00 - j2.60$	$4.45 - j3.30$

Z_{in} = Device input impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

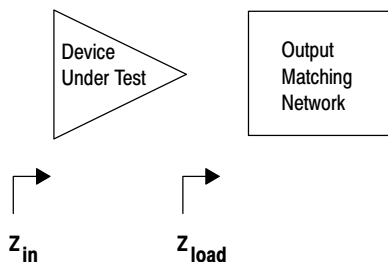
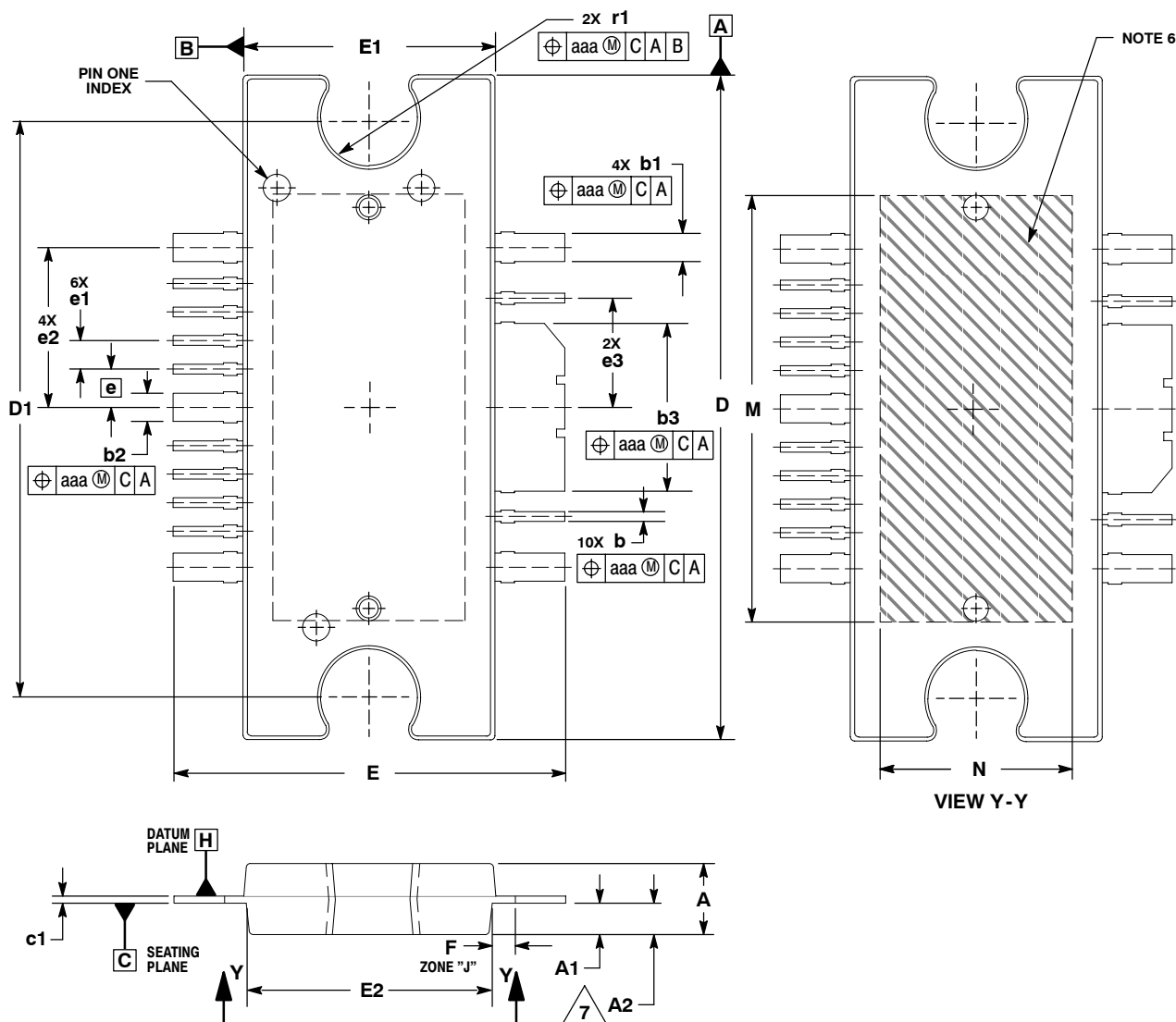


Figure 15. Series Equivalent Output Impedance

PACKAGE DIMENSIONS

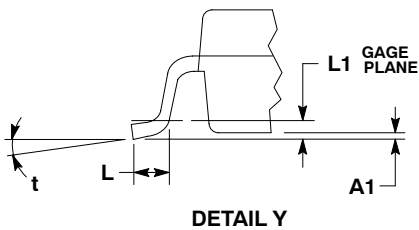
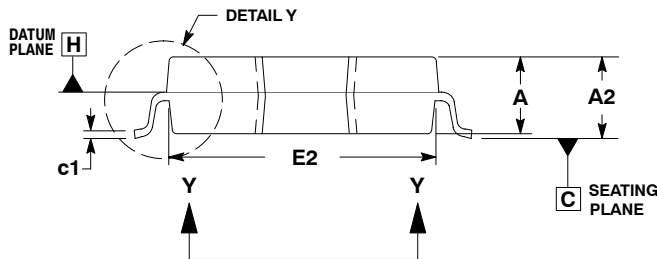
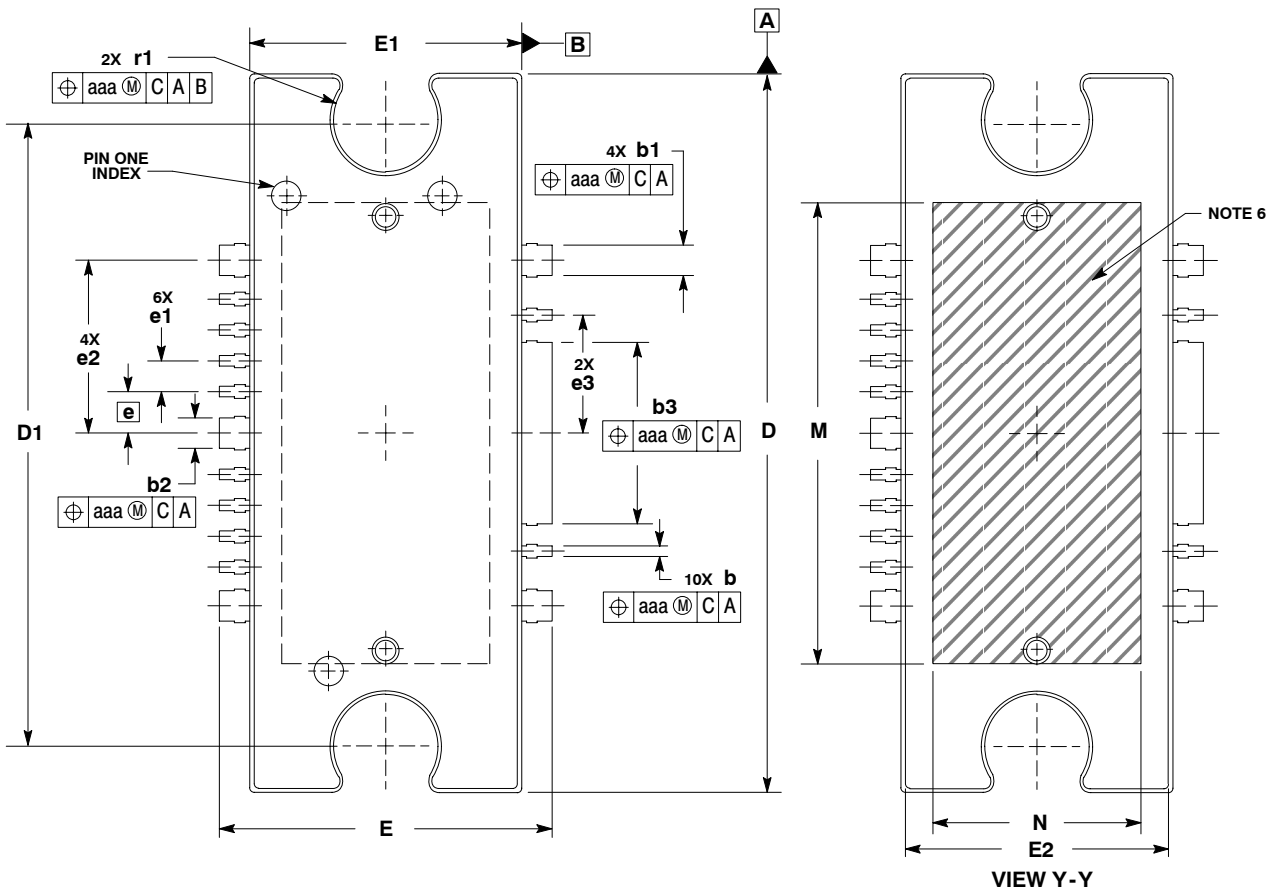


NOTES:

1. CONTROLLING DIMENSION: INCH.
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DATUM PLANE -H- IS LOCATED AT TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
4. DIMENSIONS "D" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 (0.15) PER SIDE. DIMENSIONS "D" AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
5. DIMENSIONS "b", "b1", "b2" AND "b3" DO NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 (0.13) TOTAL IN EXCESS OF THE "b", "b1", "b2" AND "b3" DIMENSIONS AT MAXIMUM MATERIAL CONDITION.
6. HATCHING REPRESENTS THE EXPOSED AREA OF THE HEAT SLUG.
7. DIM A2 APPLIES WITHIN ZONE "J" ONLY.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.100	.104	2.54	2.64
A1	.038	.044	0.96	1.12
A2	.040	.042	1.02	1.07
D	.928	.932	23.57	23.67
D1	.810	BSC	20.57	BSC
E	.551	.559	14.00	14.20
E1	.353	.357	8.97	9.07
E2	.346	.350	8.79	8.89
F	.025	BSC	0.64	BSC
M	.600	---	15.24	---
N	.270	---	6.86	---
b	.011	.017	0.28	0.43
b1	.037	.043	0.94	1.09
b2	.037	.043	0.94	1.09
b3	.225	.231	5.72	5.87
c1	.007	.011	.18	.28
e	.054	BSC	1.37	BSC
e1	.040	BSC	1.02	BSC
e2	.224	BSC	5.69	BSC
e3	.150	BSC	3.81	BSC
r1	.063	.068	1.6	1.73
aaa	.004	---	.10	---

**CASE 1329-09
ISSUE J
TO-272 WB-16
PLASTIC
MW4IC2020MBR1**



NOTES:

1. CONTROLLING DIMENSION: INCH.
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DATUM PLANE -H- IS LOCATED AT TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
4. DIMENSIONS "D" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 (0.15) PER SIDE. DIMENSIONS "D" AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
5. DIMENSIONS "b", "b1", "b2" AND "b3" DO NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 (0.13) TOTAL IN EXCESS OF THE "b", "b1", "b2" AND "b3" DIMENSIONS AT MAXIMUM MATERIAL CONDITION.
6. HATCHING REPRESENTS THE EXPOSED AREA OF THE HEAT SINK.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.100	.104	2.54	2.64
A1	.001	.004	0.02	0.10
A2	.099	.110	2.51	2.79
D	.928	.932	23.57	23.67
D1	.810	BSC	20.57	BSC
E	.429	.437	10.90	11.10
E1	.353	.357	8.97	9.07
E2	.346	.350	8.79	8.89
L	.018	.024	4.90	5.06
L1	.01	BSC	0.25	BSC
M	.600	---	15.24	---
N	.270	---	6.86	---
b	.011	.017	0.28	0.43
b1	.037	.043	0.94	1.09
b2	.037	.043	0.94	1.09
b3	.225	.231	5.72	5.87
c1	.007	.011	.18	.28
e	.054	BSC	1.37	BSC
e1	.040	BSC	1.02	BSC
e2	.224	BSC	5.69	BSC
e3	.150	BSC	3.81	BSC
r1	.063	.068	1.6	1.73
t	2°	8°	2°	8°
aaa	.004	---	.10	---

**CASE 1329A-03
ISSUE B
TO-272 WB-16 GULL
PLASTIC
MW4IC2020GMBR1**

Information in this document is provided solely to enable system and software implementers to use Motorola products. There are no express or implied copyright licenses granted hereunder to design or fabricate any integrated circuits or integrated circuits based on the information in this document.

Motorola reserves the right to make changes without further notice to any products herein. Motorola makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does Motorola assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. "Typical" parameters that may be provided in Motorola data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals", must be validated for each customer application by customer's technical experts. Motorola does not convey any license under its patent rights nor the rights of others. Motorola products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the Motorola product could create a situation where personal injury or death may occur. Should Buyer purchase or use Motorola products for any such unintended or unauthorized application, Buyer shall indemnify and hold Motorola and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that Motorola was negligent regarding the design or manufacture of the part.

MOTOROLA and the Stylized M Logo are registered in the US Patent and Trademark Office. All other product or service names are the property of their respective owners. Motorola, Inc. is an Equal Opportunity/Affirmative Action Employer.

© Motorola Inc. 2004

HOW TO REACH US:

USA/EUROPE/LOCATIONS NOT LISTED:
Motorola Literature Distribution
P.O. Box 5405, Denver, Colorado 80217
1-800-521-6274 or 480-768-2130

JAPAN: Motorola Japan Ltd.; SPS, Technical Information Center,
3-20-1, Minami-Azabu, Minato-ku, Tokyo 106-8573, Japan
81-3-3440-3569

ASIA/PACIFIC: Motorola Semiconductors H.K. Ltd.; Silicon Harbour Centre,
2 Dai King Street, Tai Po Industrial Estate, Tai Po, N.T., Hong Kong
852-26668334

HOME PAGE: <http://motorola.com/semiconductors>

